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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Not For New Designs
Core Processor	R8C
Core Size	16-Bit
Speed	20MHz
Connectivity	I ² C, LINbus, SIO, SSU, UART/USART
Peripherals	LCD, POR, PWM, Voltage Detect, WDT
Number of I/O	56
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-20°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LFQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f2la66anfp-30

1.1.2 Differences between Groups

Table 1.1 lists the Differences between Groups, Tables 1.2 and 1.3 list the Programmable I/O Ports Provided for Each Group, and Tables 1.4 and 1.5 list the LCD Display Function Pins Provided for Each Group.

Figures 1.9 to 1.12 show the pin assignment for each group, and Tables 1.9 to 1.12 list product information.

The explanations in the chapters which follow apply to the R8C/LA8A Group only. Note the differences shown below.

Table 1.1 Differences between Groups

Item	Function	R8C/LA3A Group	R8C/LA5A Group	R8C/LA6A Group	R8C/LA8A Group
I/O Ports	Programmable I/O ports	26 pins	44 pins	56 pins	72 pins
	High current drive ports	8 pins	8 pins	8 pins	10 pins
Interrupts	$\overline{\text{INT}}$ interrupt pins	5 pins	6 pins	8 pins	8 pins
Timer RJ	Timer RJ0 output pin	None	None	None	1 pin
	Timer RJ1 output pin	None	None	None	1 pin
	Timer RJ2 I/O pin	None	None	None	1 pin
	Timer RJ2 output pin	None	None	None	1 pin
Timer RH	Timer RH output pin	None	1 pin	1 pin	1 pin
Serial interface	UART2	None	None	1 pin	1 pin
A/D Converter	Analog input pins	5 pins	7 pins	8 pins	12 pins
LCD Drive Control Circuit	Segment output pins	Max. 11 pins	Max. 27 pins	Max. 32 pins	Max. 40 pins
Comparator B	Analog input voltage	1 pin	2 pins	2 pins	2 pins
	Reference input voltage	1 pin	2 pins	2 pins	2 pins
Clock	XCIN pin	Shared with XIN pin	Dedicated pin	Dedicated pin	Dedicated pin
	XCOUT pin	Shared with XOUT pin	Dedicated pin	Dedicated pin	Dedicated pin
Packages		32-pin LQFP	52-pin LQFP	64-pin LQFP	80-pin LQFP

Note:

1. I/O ports are shared with I/O functions, such as interrupts or timers.
Refer to Tables 1.13 to 1.17, Pin Name Information by Pin Number, for details.

1.1.3 Specifications

Tables 1.6 to 1.8 list the specifications.

Table 1.6 Specifications (1)

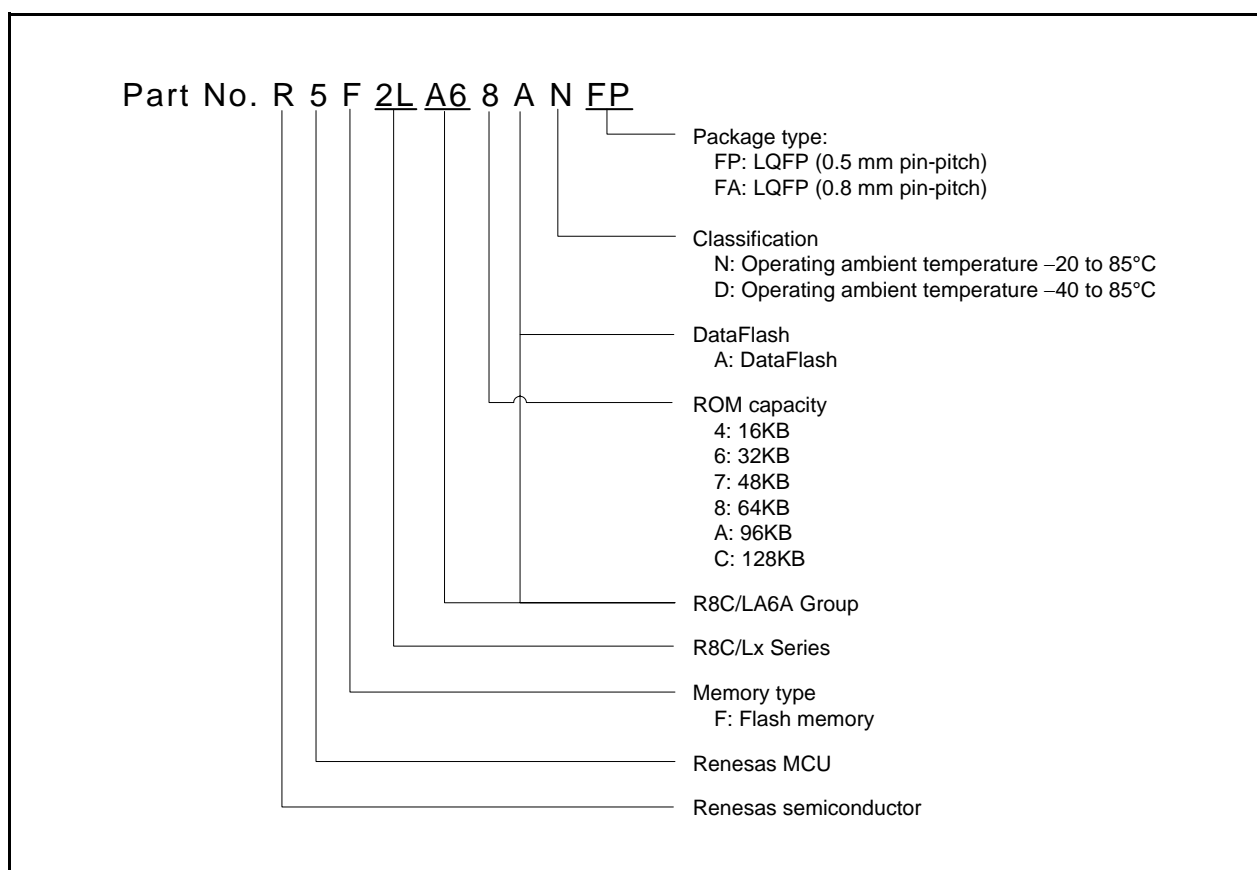
Item	Function		Specification
CPU	Central processing unit		R8C CPU core <ul style="list-style-type: none">• Number of fundamental instructions: 89• Minimum instruction execution time: 50 ns (f(XIN) = 20 MHz, VCC = 2.7 V to 5.5 V) 125 ns (f(XIN) = 8 MHz, VCC = 1.8 V to 5.5 V)• Multiplier: 16 bits × 16 bits → 32 bits• Multiply-accumulate instruction: 16 bits × 16 bits + 32 bits → 32 bits• Operating mode: Single-chip mode (address space: 1 Mbyte)
Memory	ROM/RAM Data flash		Refer to Tables 1.9 to 1.12 Product Lists.
Power Supply Voltage Detection	Voltage detection circuit		<ul style="list-style-type: none">• Power-on reset• Voltage detection 3 (detection level of voltage detection 0 and voltage detection 1 selectable)
I/O Ports	Programmable I/O ports	R8C/LA3A Group	<ul style="list-style-type: none">• CMOS I/O ports: 26, selectable pull-up resistor ⁽¹⁾• High current drive ports: 8
		R8C/LA5A Group	<ul style="list-style-type: none">• CMOS I/O ports: 44, selectable pull-up resistor ⁽¹⁾• High current drive ports: 8
		R8C/LA6A Group	<ul style="list-style-type: none">• CMOS I/O ports: 56, selectable pull-up resistor ⁽¹⁾• High current drive ports: 8
		R8C/LA8A Group	<ul style="list-style-type: none">• CMOS I/O ports: 72, selectable pull-up resistor ⁽¹⁾• High current drive ports: 10
Clock	Clock generation circuits		4 circuits: XIN clock oscillation circuit XCIN clock oscillation circuit (32 kHz) High-speed on-chip oscillator (with frequency adjustment function) Low-speed on-chip oscillator <ul style="list-style-type: none">• Oscillation stop detection: XIN clock oscillation stop detection function• Frequency divider circuit: Division ratio selectable from 1, 2, 4, 8, and 16• Low-power-consumption modes: Standard operating mode (high-speed clock, low-speed clock, high-speed on-chip oscillator, low-speed on-chip oscillator), wait mode, stop mode, power-off mode
			Real-time clock (timer RH)
Interrupts		R8C/LA3A Group	<ul style="list-style-type: none">• Number of interrupt vectors: 69• External Interrupt: 13 (INT × 5, key input × 8)• Priority levels: 7 levels
		R8C/LA5A Group	<ul style="list-style-type: none">• Number of interrupt vectors: 69• External Interrupt: 14 (INT × 6, key input × 8)• Priority levels: 7 levels
		R8C/LA6A Group	<ul style="list-style-type: none">• Number of interrupt vectors: 69
		R8C/LA8A Group	<ul style="list-style-type: none">• External Interrupt: 16 (INT × 8, key input × 8)• Priority levels: 7 levels
Watchdog Timer			<ul style="list-style-type: none">• 14 bits × 1 (with prescaler)• Selectable reset start function• Selectable low-speed on-chip oscillator for watchdog timer

Note:

1. No pull-up resistor is provided in the pins P5_4 to P5_6.

Table 1.11 Product List for R8C/LA6A Group**Current of Oct 2011**

Part No.	Internal ROM Capacity		Internal RAM Capacity	Package Type	Remarks
	Program ROM	Data Flash			
R5F2LA64ANFP	16 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064KB-A	N Version
R5F2LA64ANFA	16 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064GA-A	
R5F2LA66ANFP	32 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064KB-A	
R5F2LA66ANFA	32 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064GA-A	
R5F2LA67ANFP	48 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064KB-A	
R5F2LA67ANFA	48 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064GA-A	
R5F2LA68ANFP	64 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064KB-A	
R5F2LA68ANFA	64 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064GA-A	
R5F2LA6AANFP	96 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064KB-A	
R5F2LA6AANFA	96 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064GA-A	
R5F2LA6CANFP	128 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064KB-A	
R5F2LA6CANFA	128 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064GA-A	
R5F2LA64ADFP	16 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064KB-A	D Version
R5F2LA64ADFA	16 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064GA-A	
R5F2LA66ADFP	32 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064KB-A	
R5F2LA66ADFA	32 Kbytes	1 Kbyte × 2	2 Kbytes	PLQP0064GA-A	
R5F2LA67ADFP	48 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064KB-A	
R5F2LA67ADFA	48 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064GA-A	
R5F2LA68ADFP	64 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064KB-A	
R5F2LA68ADFA	64 Kbytes	1 Kbyte × 2	3.5 Kbytes	PLQP0064GA-A	
R5F2LA6AADFP	96 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064KB-A	
R5F2LA6AADFA	96 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064GA-A	
R5F2LA6CADFP	128 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064KB-A	
R5F2LA6CADFA	128 Kbytes	2 Kbytes × 2	5.5 Kbytes	PLQP0064GA-A	

**Figure 1.3 Correspondence of Part No., with Memory Size and Package of R8C/LA6A Group**

1.4 Pin Assignments

Figures 1.9 to 1.12 show pin assignments (top view). Tables 1.13 to 1.17 list the pin name information by pin number.

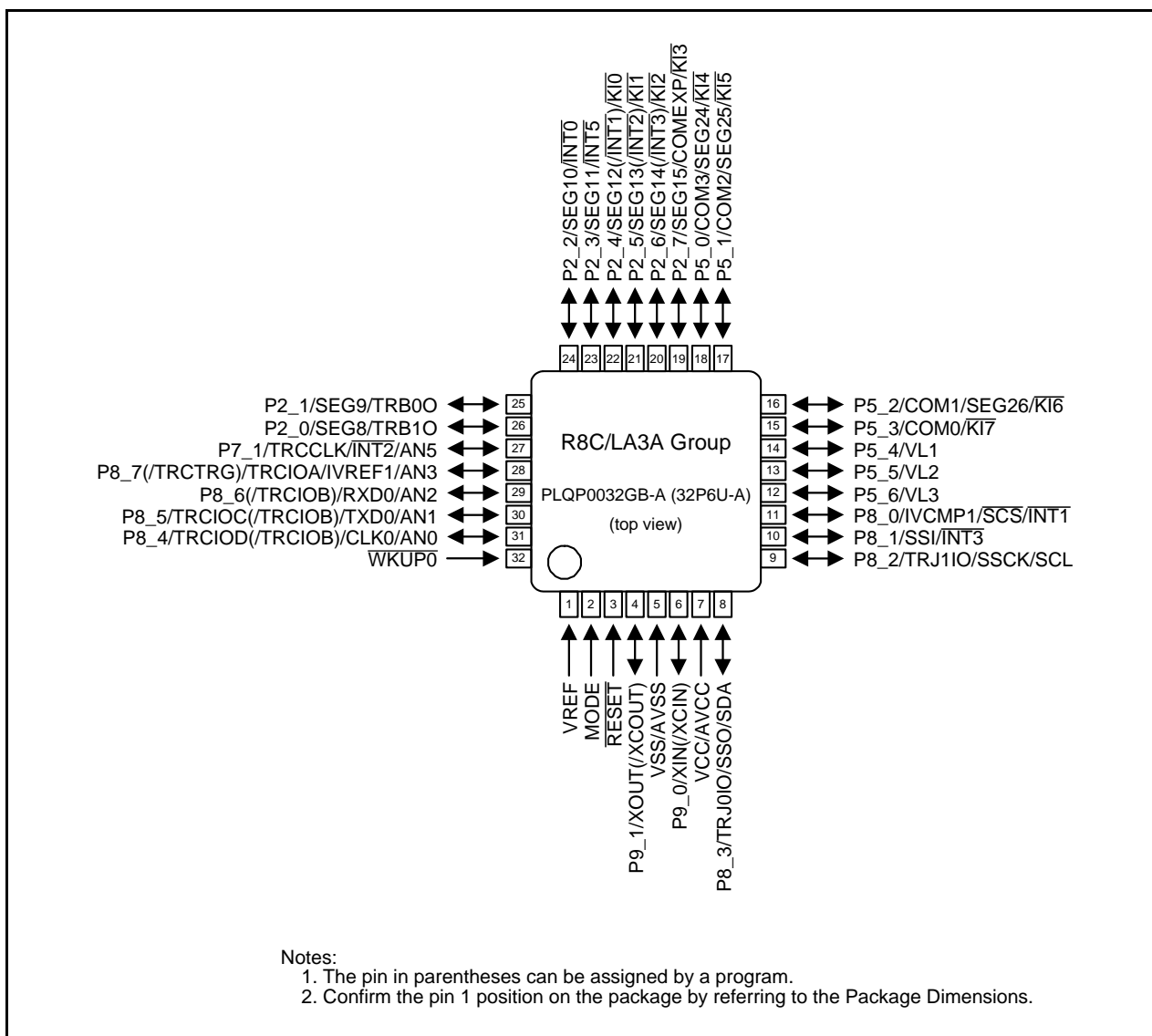


Figure 1.9 Pin Assignment (Top View) of PLQP0032GB-A Package

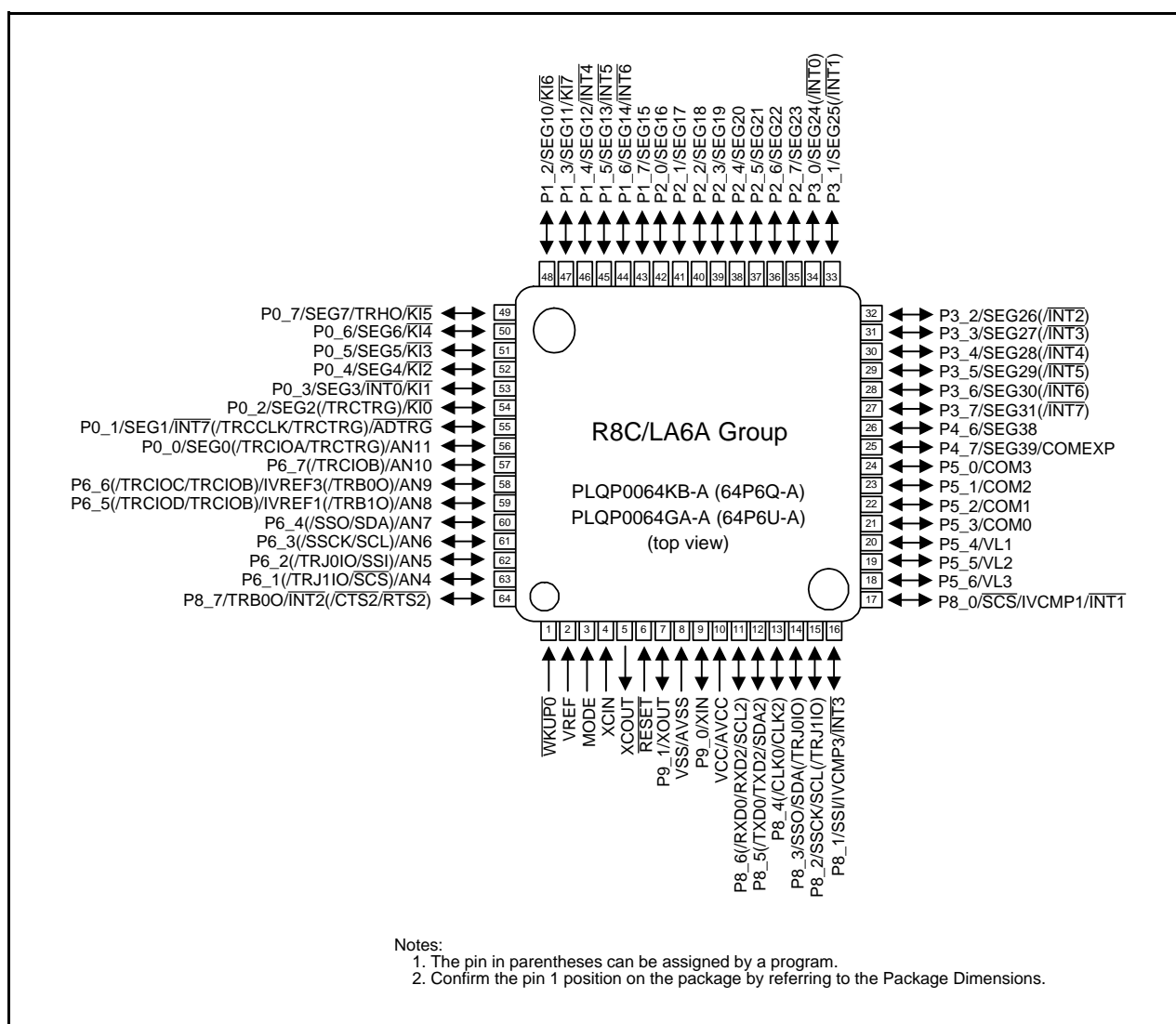


Figure 1.11 Pin Assignment (Top View) of PLQP0064KB-A and PLQP0064GA-A Packages

Table 1.15 Pin Name Information by Pin Number (R8C/LA6A Group, R8C/LA8A Group)(1)

Pin Number		Control Pin	Port	I/O Pin Functions for Peripheral Modules						
LA8A	LA6A			Interrupt	Timer	Serial Interface	SSU	I ² C bus	A/D Converter, Comparator B	LCD drive Control Circuit
1			P7_1		TRJ1O	(TXD2/SDA2/RXD2/SCL2)				
2		WKUP1	P7_0		TRJ2O	(CLK2)				
3	64		P8_7	INT2	TRB0O	(CTS2/RTS2)				
4	1	WKUP0								
5	2	VREF								
6	3	MODE								
7	4	XCIN								
8	5	XCOUT								
9	6	RESET								
10	7	XOUT	P9_1							
11	8	VSS/AVSS								
12	9	XIN	P9_0							
13	10	VCC/AVCC								
14	11		P8_6			(RXD0/RXD2/SCL2)				
15	12		P8_5			(TXD0/TXD2/SDA2)				
16	13		P8_4			(CLK0/CLK2)				
17	14		P8_3		(TRJ0IO)		SSO	SDA		
18	15		P8_2		(TRJ1IO)		SSCK	SCL		
19	16		P8_1	INT3			SSI		IVCMP3	
20	17		P8_0	INT1			SCS		IVCMP1	
21	18		P5_6							VL3
22	19		P5_5							VL2
23	20		P5_4							VL1
24	21		P5_3							COM0
25	22		P5_2							COM1
26	23		P5_1							COM2
27	24		P5_0							COM3
28	25		P4_7							SEG39/COMEXP
29	26		P4_6							SEG38
30			P4_5							SEG37

Note:

1. The pin in parentheses can be assigned by a program.

Table 1.19 Pin Functions for R8C/LA5A Group (2)

Item	Pin Name	I/O Type	Description
I ² C bus	SCL	I/O	Clock I/O pin.
	SDA	I/O	Data I/O pin.
SSU	SSI	I/O	Data I/O pin.
	$\overline{\text{SCS}}$	I/O	Chip-select signal I/O pin.
	SSCK	I/O	Clock I/O pin.
	SSO	I/O	Data I/O pin.
Reference voltage input	VREF	I	Reference voltage input pin for the A/D converter.
A/D converter	AN0 to AN6	I	A/D converter analog input pins.
	$\overline{\text{ADTRG}}$	I	AD external trigger input pin.
Comparator B	IVCMP1, IVCMP3	I	Comparator B analog voltage input pins.
	IVREF1, IVREF3	I	Comparator B reference voltage input pins.
I/O ports	P0_0 to P0_7, P2_0 to P2_7, P3_0 to P3_7, P5_0 to P5_6, P7_0 to P7_2, P8_0 to P8_7, P9_0, P9_1	I/O	CMOS I/O ports. Each port has an I/O select direction register, allowing each pin in the port to be directed for input or output individually. Any port set to input can be set to use a pull-up resistor or not by a program. Port P8 can be used as LED drive ports.
Segment output	SEG0 to SEG26	O	LCD segment output pins.
Common output	COM0 to COM3, COMEXP	O	LCD common output pins.
LCD power supply	VL1	I	Apply the following voltage: $1\text{ V} \leq \text{VL1} \leq \text{VCC}$ and $\text{VL1} \leq \text{VL2}$.
	VL2	I	Apply the following voltage: $\text{VL2} \leq 5.5\text{ V}$ and $\text{VL1} \leq \text{VL2} \leq \text{VL3}$.
	VL3	I	Apply the following voltage: $\text{VL3} \leq 5.5\text{ V}$ and $\text{VL2} \leq \text{VL3}$.

I: Input O: Output I/O: Input and output

Note:

1. Contact the oscillator manufacturer for oscillation characteristics.

Table 1.20 Pin Functions for R8C/LA8A Group (1)

Item	Pin Name	I/O Type	Description
Power supply input	VCC, VSS	—	Apply 1.8 V to 5.5 V to the VCC pin. Apply 0 V to the VSS pin.
Analog power supply input	AVCC, AVSS	—	Power supply for the A/D converter. Connect a capacitor between AVCC and AVSS.
Reset input	RESET	I	Driving this pin low resets the MCU.
MODE	MODE	I	Connect this pin to VCC via a resistor.
Power-off 0 mode exit input	WKUP0	I	This pin is provided for input to exit the mode used in power-off 0 mode. Connect to VSS when not using power-off 0 mode.
	WKUP1	I	This pin is provided for input to exit the mode used in power-off 0 mode.
XIN clock input	XIN	I	These pins are provided for XIN clock generation circuit I/O. Connect a ceramic oscillator or a crystal oscillator between pins XIN and XOUT. ⁽¹⁾ To use an external clock, input it to the XIN pin and set XOUT as the I/O port P9_1. When the pin is not used, treat it as an unassigned pin and use the appropriate handling.
XIN clock output	XOUT	O	
XCIN clock input	XCIN	I	These pins are provided for XCIN clock generation circuit I/O. Connect a crystal oscillator between pins XCIN and XCOUNT. ⁽¹⁾ To use an external clock, input it to the XCIN pin and leave the XCOUNT pin open.
XCIN clock output	XCOUT	O	
INT interrupt input	INT0 to INT7	I	INT interrupt input pins.
Key input interrupt	KI0 to KI7	I	Key input interrupt input pins.
Timer RB	TRB0O, TRB1O	O	Timer RB output pins.
Timer RC	TRCCLK	I	External clock input pin.
	TRCTRIG	I	External trigger input pin.
	TRCIOA, TRCIOB, TRCIOC, TRCIOD	I/O	Timer RC I/O pins.
Timer RH	TRHO	O	Timer RH output pin.
Timer RJ	TRJ0IO, TRJ1IO, TRJ2IO	I/O	Timer RJ I/O pins.
	TRJ0IO, TRJ1IO, TRJ2IO	O	Timer RJ output pins.
Serial interface	CLK0, CLK2	I/O	Transfer clock I/O pin.
	RXD0, RXD2	I	Serial data input pin.
	TXD0, TXD2	O	Serial data output pin.
	CTS2	I	Transmission control input pin.
	RTS2	O	Reception control output pin.
	SCL2	I/O	I ² C mode clock I/O pin.
	SDA2	I/O	I ² C mode data I/O pin.

I: Input O: Output I/O: Input and output

Note:

1. Contact the oscillator manufacturer for oscillation characteristics.

Table 1.21 Pin Functions for R8C/LA8A Group (2)

Item	Pin Name	I/O Type	Description
I ² C bus	SCL	I/O	Clock I/O pin.
	SDA	I/O	Data I/O pin.
SSU	SSI	I/O	Data I/O pin.
	$\overline{\text{SCS}}$	I/O	Chip-select signal I/O pin.
	SSCK	I/O	Clock I/O pin.
	SSO	I/O	Data I/O pin.
Reference voltage input	VREF	I	Reference voltage input pin for the A/D converter.
A/D converter	AN0 to AN11	I	A/D converter analog input pins.
	$\overline{\text{ADTRG}}$	I	AD external trigger input pin.
Comparator B	IVCMP1, IVCMP3	I	Comparator B analog voltage input pins.
	IVREF1, IVREF3	I	Comparator B reference voltage input pins.
I/O ports	P0_0 to P0_7, P1_0 to P1_7, P2_0 to P2_7, P3_0 to P3_7, P4_0 to P4_7, P5_0 to P5_6, P6_0 to P6_7, P7_0 to P7_6, P8_0 to P8_7, P9_0, P9_1	I/O	CMOS I/O ports. Each port has an I/O select direction register, allowing each pin in the port to be directed for input or output individually. Any port set to input can be set to use a pull-up resistor or not by a program. Ports P7_0, P7_1 and P8 can be used as LED drive ports.
Segment output	SEG0 to SEG39	O	LCD segment output pins.
Common output	COM0 to COM3, COMEXP	O	LCD common output pins.
LCD power supply	VL1	I	Apply the following voltage: $1\text{ V} \leq \text{VL1} \leq \text{VCC}$ and $\text{VL1} \leq \text{VL2}$.
	VL2	I	Apply the following voltage: $\text{VL2} \leq 5.5\text{ V}$ and $\text{VL1} \leq \text{VL2} \leq \text{VL3}$.
	VL3	I	Apply the following voltage: $\text{VL3} \leq 5.5\text{ V}$ and $\text{VL2} \leq \text{VL3}$.

I: Input O: Output I/O: Input and output

Note:

1. Contact the oscillator manufacturer for oscillation characteristics.

2.1 Data Registers (R0, R1, R2, and R3)

R0 is a 16-bit register for transfer, arithmetic, and logic operations. The same applies to R1 to R3. R0 can be split into high-order bits (R0H) and low-order bits (R0L) to be used separately as 8-bit data registers. R1H and R1L are analogous to R0H and R0L. R2 can be combined with R0 and used as a 32-bit data register (R2R0). R3R1 is analogous to R2R0.

2.2 Address Registers (A0 and A1)

A0 is a 16-bit register for address register indirect addressing and address register relative addressing. It is also used for transfer, arithmetic, and logic operations. A1 is analogous to A0. A1 can be combined with A0 and as a 32-bit address register (A1A0).

2.3 Frame Base Register (FB)

FB is a 16-bit register for FB relative addressing.

2.4 Interrupt Table Register (INTB)

INTB is a 20-bit register that indicates the starting address of an interrupt vector table.

2.5 Program Counter (PC)

PC is 20 bits wide and indicates the address of the next instruction to be executed.

2.6 User Stack Pointer (USP) and Interrupt Stack Pointer (ISP)

The stack pointers (SP), USP and ISP, are each 16 bits wide. The U flag of FLG is used to switch between USP and ISP.

2.7 Static Base Register (SB)

SB is a 16-bit register for SB relative addressing.

2.8 Flag Register (FLG)

FLG is an 11-bit register indicating the CPU state.

2.8.1 Carry Flag (C)

The C flag retains carry, borrow, or shift-out bits that have been generated by the arithmetic and logic unit.

2.8.2 Debug Flag (D)

The D flag is for debugging only. Set it to 0.

2.8.3 Zero Flag (Z)

The Z flag is set to 1 when an arithmetic operation results in 0; otherwise to 0.

2.8.4 Sign Flag (S)

The S flag is set to 1 when an arithmetic operation results in a negative value; otherwise to 0.

2.8.5 Register Bank Select Flag (B)

Register bank 0 is selected when the B flag is 0. Register bank 1 is selected when this flag is set to 1.

2.8.6 Overflow Flag (O)

The O flag is set to 1 when an operation results in an overflow; otherwise to 0.

Table 4.13 SFR Information for R8C/LA8A Group (4) ⁽¹⁾

Address	Register	Symbol	After Reset
00C0h	A/D Register 0	AD0	XXh
00C1h			000000XXb
00C2h	A/D Register 1	AD1	XXh
00C3h			000000XXb
00C4h	A/D Register 2	AD2	XXh
00C5h			000000XXb
00C6h	A/D Register 3	AD3	XXh
00C7h			000000XXb
00C8h	A/D Register 4	AD4	XXh
00C9h			000000XXb
00CAh	A/D Register 5	AD5	XXh
00CBh			000000XXb
00CCh	A/D Register 6	AD6	XXh
00CDh			000000XXb
00CEh	A/D Register 7	AD7	XXh
00CFh			000000XXb
00D0h			
00D1h			
00D2h			
00D3h			
00D4h	A/D Mode Register	ADMOD	00h
00D5h	A/D Input Select Register	ADINSEL	11000000b
00D6h	A/D Control Register 0	ADCON0	00h
00D7h	A/D Control Register 1	ADCON1	00h
00D8h			
00D9h			
00DAh			
00DBh			
00DCh			
00DDh	A/D Control Register 2	ADCON2	00h
00DEh			
00DFh			
00E0h	Port P0 Register	P0	XXh
00E1h	Port P1 Register	P1	XXh
00E2h	Port P0 Direction Register	PD0	00h
00E3h	Port P1 Direction Register	PD1	00h
00E4h	Port P2 Register	P2	XXh
00E5h	Port P3 Register	P3	XXh
00E6h	Port P2 Direction Register	PD2	00h
00E7h	Port P3 Direction Register	PD3	00h
00E8h	Port P4 Register	P4	XXh
00E9h	Port P5 Register	P5	XXh
00EAh	Port P4 Direction Register	PD4	00h
00EBh	Port P5 Direction Register	PD5	00h
00ECh	Port P6 Register	P6	XXh
00EDh	Port P7 Register	P7	XXh
00EEh	Port P6 Direction Register	PD6	00h
00EFh	Port P7 Direction Register	PD7	00h
00F0h	Port P8 Register	P8	XXh
00F1h	Port P9 Register	P9	XXh
00F2h	Port P8 Direction Register	PD8	00h
00F3h	Port P9 Direction Register	PD9	00h
00F4h			
00F5h			
00F6h			
00F7h			
00F8h			
00F9h			
00FAh			
00FBh			
00FCh			
00FDh			
00FEh			
00FFh			

X: Undefined

Note:

- Blank spaces are reserved. No access is allowed.

5. Electrical Characteristics

5.1 Electrical Characteristics (R8C/LA3A Group and R8C/LA5A Group)

5.1.1 Absolute Maximum Ratings

Table 5.1 Absolute Maximum Ratings

Symbol	Parameter		Condition	Rated Value	Unit
V _{cc} /AV _{cc}	Supply voltage			−0.3 to 6.5	V
V _i	Input voltage	XIN	XIN-XOUT oscillation on (oscillation buffer ON) ⁽¹⁾	−0.3 to 1.9	V
		XIN	XIN-XOUT oscillation on (oscillation buffer OFF) ⁽¹⁾	−0.3 to V _{cc} + 0.3	V
		P5_4/VL1		−0.3 to VL2 ⁽²⁾	V
		P5_5/VL2		VL1 to VL3	V
		P5_6/VL3		VL2 to 6.5	V
		Other pins		−0.3 to V _{cc} + 0.3	V
V _o	Output voltage	XOUT	XIN-XOUT oscillation on (oscillation buffer ON) ⁽¹⁾	−0.3 to 1.9	V
		XOUT	XIN-XOUT oscillation on (oscillation buffer OFF) ⁽¹⁾	−0.3 to V _{cc} + 0.3	V
		COM0 to COM3		−0.3 to VL3	V
		SEG0 to SEG26		−0.3 to VL3	V
		Other pins		−0.3 to V _{cc} + 0.3	V
P _d	Power dissipation		−40 °C ≤ T _{opr} ≤ 85 °C	500	mW
T _{opr}	Operating ambient temperature			−20 to 85 (N version)/ −40 to 85 (D version)	°C
T _{stg}	Storage temperature			−65 to 150	°C

Notes:

- For the register settings for each operation, refer to **7. I/O Ports** and **9. Clock Generation Circuit** in the User's Manual: Hardware.
- The VL1 voltage should be VCC or below.

Table 5.7 Flash Memory (Program ROM) Characteristics
(VCC = 1.8 to 5.5 V and T_{opr} = 0 to 60 °C, unless otherwise specified.)

Symbol	Parameter	Conditions	Standard			Unit
			Min.	Typ.	Max.	
—	Program/erase endurance ⁽¹⁾		10,000 ⁽²⁾	—	—	times
—	Byte program time		—	80	—	μs
—	Block erase time		—	0.12	—	s
t _d (SR-SUS)	Time delay from suspend request until suspend		—	—	0.25 + CPU clock × 3 cycles	ms
—	Time from suspend until erase restart		—	—	30 + CPU clock × 1 cycle	μs
t _d (CMDRST-READY)	Time from when command is forcibly terminated until reading is enabled		—	—	30 + CPU clock × 1 cycle	μs
—	Program, erase voltage		1.8	—	5.5	V
—	Read voltage		1.8	—	5.5	V
—	Program, erase temperature		0	—	60	°C
—	Data hold time ⁽⁶⁾	Ambient temperature = 85 °C	10	—	—	year

Notes:

- Definition of programming/erasure endurance
 The programming and erasure endurance is defined on a per-block basis.
 If the programming and erasure endurance is n (n = 1,000), each block can be erased n times. For example, if 1,024 1-byte writes are performed to different addresses in block A, a 1 Kbyte block, and then the block is erased, the programming/erasure endurance still stands at one.
 However, the same address must not be programmed more than once per erase operation (overwriting prohibited).
- Endurance to guarantee all electrical characteristics after program and erase. (1 to Min. value can be guaranteed).
- In a system that executes multiple programming operations, the actual erasure count can be reduced by writing to sequential addresses in turn so that as much of the block as possible is used up before performing an erase operation. For example, when programming groups of 16 bytes, the effective number of rewrites can be minimized by programming up to 128 groups before erasing them all in one operation. It is also advisable to retain data on the erasure endurance of each block and limit the number of erase operations to a certain number.
- If an error occurs during block erase, attempt to execute the clear status register command, then execute the block erase command at least three times until the erase error does not occur.
- Customers desiring program/erase failure rate information should contact their Renesas technical support representative.
- The data hold time includes time that the power supply is off or the clock is not supplied.

Table 5.8 Flash Memory (Data flash Block A and Block B) Characteristics
(V_{CC} = 1.8 to 5.5 V and T_{opr} = –20 to 85 °C (N version)/ –40 to 85 °C (D version), unless otherwise specified.)

Symbol	Parameter	Conditions	Standard			Unit
			Min.	Typ.	Max.	
–	Program/erase endurance ⁽¹⁾		10,000 (2)	–	–	time s
–	Byte program time (program/erase endurance ≤ 10,000 times)		–	150	–	μs
–	Block erase time (program/erase endurance ≤ 10,000 times)		–	0.05	1	s
t _d (SR-SUS)	Time delay from suspend request until suspend		–	–	0.25 + CPU clock × 3 cycles	ms
–	Time from suspend until erase restart		–	–	30 + CPU clock × 1 cycle	μs
t _d (CMDRST-READY)	Time from when command is forcibly terminated until reading is enabled		–	–	30 + CPU clock × 1 cycle	μs
–	Program, erase voltage		1.8	–	5.5	V
–	Read voltage		1.8	–	5.5	V
–	Program, erase temperature		–20 ⁽⁶⁾	–	85	°C
–	Data hold time ⁽⁷⁾	Ambient temperature = 85 °C	10	–	–	year

Notes:

- Definition of programming/erasure endurance
 The programming and erasure endurance is defined on a per-block basis.
 If the programming and erasure endurance is n (n = 10,000), each block can be erased n times. For example, if 1,024 1-byte writes are performed to different addresses in block A, a 1 Kbyte block, and then the block is erased, the programming/erasure endurance still stands at one.
 However, the same address must not be programmed more than once per erase operation (overwriting prohibited).
- Endurance to guarantee all electrical characteristics after program and erase. (1 to Min. value can be guaranteed).
- In a system that executes multiple programming operations, the actual erasure count can be reduced by writing to sequential addresses in turn so that as much of the block as possible is used up before performing an erase operation. For example, when programming groups of 16 bytes, the effective number of rewrites can be minimized by programming up to 128 groups before erasing them all in one operation. In addition, averaging the erasure endurance between blocks A and B can further reduce the actual erasure endurance. It is also advisable to retain data on the erasure endurance of each block and limit the number of erase operations to a certain number.
- If an error occurs during block erase, attempt to execute the clear status register command, then execute the block erase command at least three times until the erase error does not occur.
- Customers desiring program/erase failure rate information should contact their Renesas technical support representative.
- 40 °C for D version.
- The data hold time includes time that the power supply is off or the clock is not supplied.

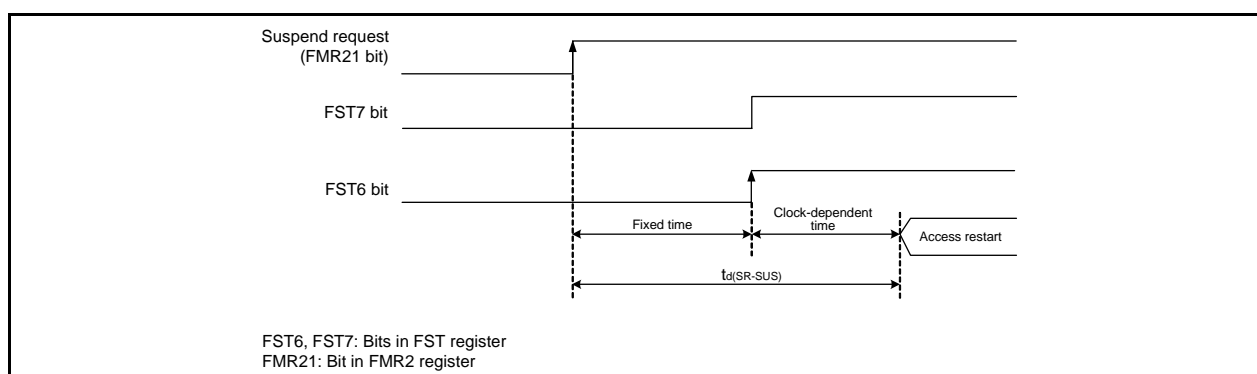


Figure 5.2 Time delay until Suspend

Table 5.11 Voltage Detection 2 Circuit Characteristics
($V_{CC} = 1.8$ to 5.5 V and $T_{opr} = -20$ to 85 °C (N version)/ -40 to 85 °C (D version), unless otherwise specified.)

Symbol	Parameter	Condition		Standard			Unit
				Min.	Typ.	Max.	
Vdet2	Voltage detection level Vdet2_0 (1)	At the falling of Vcc		3.70	4.0	4.30	V
—	Hysteresis width at the rising of Vcc in voltage detection 2 circuit			—	0.10	—	V
—	Voltage detection 2 circuit response time (2)	In operation	At the falling of Vcc from 5 V to (Vdet2_0 – 0.1) V	—	20	150	μs
		In stop mode	At the falling of Vcc from 5 V to (Vdet2_0 – 0.1) V	—	200	500	μs
—	Voltage detection circuit self power consumption	VCA27 = 1, Vcc = 5.0 V		—	1.7	—	μA
td(E-A)	Waiting time until voltage detection circuit operation starts (3)			—	—	100	μs

Notes:

1. The voltage detection level varies with detection targets. Select the level with the V_{CA24} bit in the V_{CA2} register.
2. Time until the voltage monitor 2 interrupt request is generated after the voltage passes V_{det2} .
3. Necessary time until the voltage detection circuit operates after setting to 1 again after setting the V_{CA27} bit in the V_{CA2} register to 0.

Table 5.12 Power-on Reset Circuit Characteristics (1)
($T_{opr} = -20$ to 85 °C (N version)/ -40 to 85 °C (D version), unless otherwise specified.)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
t_{rth}	External power V_{CC} rise gradient		0	—	50000	mV/ms

Note:

1. To use the power-on reset function, enable voltage monitor 0 reset by setting the $LVDAS$ bit in the OFS register to 0.

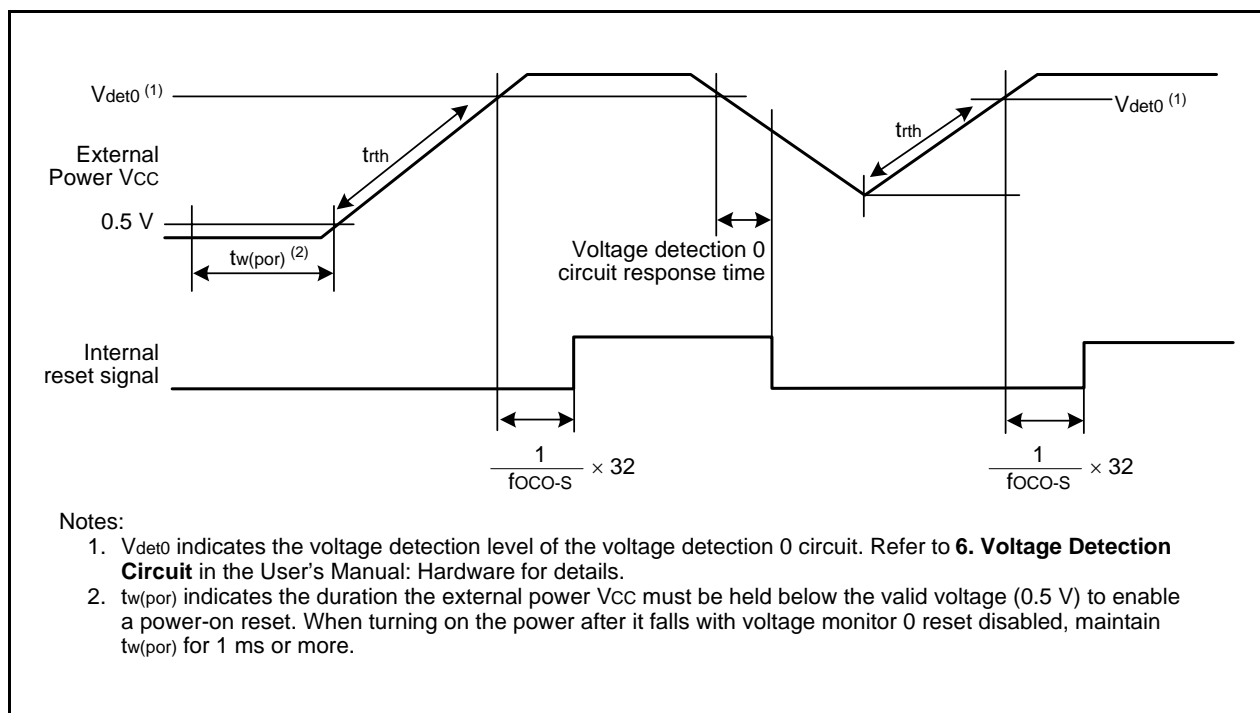


Figure 5.3 Power-on Reset Circuit Characteristics

Table 5.22 DC Characteristics (5) [1.8 V ≤ V_{CC} < 2.7 V]
(T_{opr} = −20 to 85 °C (N version)/ −40 to 85 °C (D version), unless otherwise specified.)

Symbol	Parameter		Condition		Standard			Unit
					Min.	Typ.	Max.	
V _{OH}	Output "H" voltage		Port P8 (1)	I _{OH} = −2 mA	V _{CC} − 0.5	−	V _{CC}	V
			Other pins	I _{OH} = −1 mA	V _{CC} − 0.5	−	V _{CC}	V
V _{OL}	Output "L" voltage		Port P8 (1)	I _{OL} = 2 mA	−	−	0.5	V
			Other pins	I _{OL} = 1 mA	−	−	0.5	V
V _{T+} −V _{T−}	Hysteresis	INT0, INT1, INT2, INT3, INT5, INT7, KI0, KI1, KI2, KI3, KI4, KI5, KI6, KI7, TRCIOA, TRCIOB, TRCIOC, TRCIOD, TRJ0IO, TRJ1IO, TRCTRG, TRCCLK, ADTRG, RXD0, CLK0, SSI, SCL, SDA, SSO			0.05	0.4	−	V
		RESET, WKUP0			0.1	0.8	−	V
I _{IH}	Input "H" current		V _I = 1.8 V, V _{CC} = 1.8 V		−	−	4.0	μA
I _{IL}	Input "L" current		V _I = 0 V, V _{CC} = 1.8 V		−	−	−4.0	μA
R _{PULLUP}	Pull-up resistance		V _I = 0 V, V _{CC} = 1.8 V		85	220	500	kΩ
R _{FXIN}	Feedback resistance	XIN			−	2.0	−	MΩ
R _{FXCIN}	Feedback resistance	XCIN			−	14	−	MΩ
V _{RAM}	RAM hold voltage		During stop mode		1.8	−	−	V

Note:

1. This applies when the drive capacity of the output transistor is set to High by P8DRR register. When the drive capacity is set to Low, the value of any other pin applies.

Table 5.42 High-speed On-Chip Oscillator Circuit Characteristics
($V_{CC} = 1.8$ to 5.5 V and $T_{opr} = -20$ to 85°C (N version)/ -40 to 85°C (D version), unless otherwise specified.)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
—	High-speed on-chip oscillator frequency after reset	$V_{CC} = 1.8$ V to 5.5 V $-20^{\circ}\text{C} \leq T_{opr} \leq 85^{\circ}\text{C}$	19.2	20	20.8	MHz
		$V_{CC} = 1.8$ V to 5.5 V $-40^{\circ}\text{C} \leq T_{opr} \leq 85^{\circ}\text{C}$	19.0	20	21.0	MHz
	High-speed on-chip oscillator frequency when the FRA4 register correction value is written into the FRA1 register and the FRA5 register correction value into the FRA3 register ⁽¹⁾	$V_{CC} = 1.8$ V to 5.5 V $-20^{\circ}\text{C} \leq T_{opr} \leq 85^{\circ}\text{C}$	17.694	18.432	19.169	MHz
		$V_{CC} = 1.8$ V to 5.5 V $-40^{\circ}\text{C} \leq T_{opr} \leq 85^{\circ}\text{C}$	17.510	18.432	19.353	MHz
—	Oscillation stability time		—	5	30	μs
—	Self power consumption at oscillation	$V_{CC} = 5.0$ V, $T_{opr} = 25^{\circ}\text{C}$	—	530	—	μA

Note:

1. This enables the setting errors of bit rates such as 9600 bps and 38400 bps to be 0% when the serial interface is used in UART mode.

Table 5.43 Low-speed On-Chip Oscillator Circuit Characteristics
($V_{CC} = 1.8$ to 5.5 V and $T_{opr} = -20$ to 85°C (N version)/ -40 to 85°C (D version), unless otherwise specified.)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
fOCO-S	Low-speed on-chip oscillator frequency		60	125	250	kHz
—	Oscillation stability time		—	—	35	μs
—	Self power consumption at oscillation	$V_{CC} = 5.0$ V, $T_{opr} = 25^{\circ}\text{C}$	—	2	—	μA
fOCO-WDT	Low-speed on-chip oscillator frequency for the watchdog timer		60	125	250	kHz
—	Oscillation stability time		—	—	35	μs
—	Self power consumption at oscillation	$V_{CC} = 5.0$ V, $T_{opr} = 25^{\circ}\text{C}$	—	2	—	μA

Table 5.44 Power Supply Circuit Characteristics
($V_{CC} = 1.8$ to 5.5 V, $V_{SS} = 0$ V, and $T_{opr} = 25^{\circ}\text{C}$, unless otherwise specified.)

Symbol	Parameter	Condition	Standard			Unit
			Min.	Typ.	Max.	
$t_{d(P-R)}$	Time for internal power supply stabilization during power-on ⁽¹⁾		—	—	2000	μs

Note:

1. Waiting time until the internal power supply generation circuit stabilizes during power-on.

Table 5.48 DC Characteristics (2) [4.0 V ≤ V_{CC} ≤ 5.5 V]
(T_{opr} = −20 to 85°C (N version)/ −40 to 85°C (D version), unless otherwise specified.)

Symbol	Parameter		Condition							Standard			Unit
			Oscillation Circuit		On-Chip Oscillator		CPU Clock	Low-Power-Consumption Setting	Other	Min.	Typ. (3)	Max. (3)	
			XIN (2)	XCIN	High-Speed	Low-Speed							
Icc	Power supply current (1)	High-speed clock mode	20 MHz	Off	Off	125 kHz	No division	—		—	4.7	10	mA
			16 MHz	Off	Off	125 kHz	No division	—		—	3.9	8	mA
			10 MHz	Off	Off	125 kHz	No division	—		—	2.3	—	mA
			20 MHz	Off	Off	Off	No division	FMR27 = 1 MSTCR0 = BEh MSTCR1 = 3Fh	Flash memory off Program operation on RAM Module standby setting enabled	—	3.1	—	mA
			20 MHz	Off	Off	125 kHz	Divide-by-8	—		—	1.8	—	mA
			16 MHz	Off	Off	125 kHz	Divide-by-8	—		—	1.5	—	mA
		High-speed on-chip oscillator mode	10 MHz	Off	Off	125 kHz	Divide-by-8	—		—	1.0	—	mA
			Off	Off	20 MHz	125 kHz	No division	—		—	5.0	11	mA
			Off	Off	20 MHz	125 kHz	Divide-by-8	—		—	2.1	—	mA
		Low-speed on-chip oscillator mode	Off	Off	4 MHz	125 kHz	Divide-by-16	MSTCR0 = BEh MSTCR1 = 3Fh		—	0.9	—	mA
			Off	Off	Off	125 kHz	No division	FMR27 = 1 VCA20 = 0		—	110	320	μA
		Low-speed clock mode	Off	Off	Off	125 kHz	Divide-by-8	FMR27 = 1 VCA20 = 0		—	63	220	μA
			Off	32 kHz	Off	Off	No division	FMR27 = 1 VCA20 = 0		—	60	220	μA
		Wait mode	Off	32 kHz	Off	Off	No division	FMSTP = 1 VCA20 = 0	Flash memory off Program operation on RAM	—	46	—	μA
			Off	Off	Off	125 kHz	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 VCA20 = 1	While a WAIT instruction is executed Peripheral clock operation	—	9.0	50	μA
			Off	Off	Off	125 kHz	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 VCA20 = 1 CM02 = 1 CM01 = 1	While a WAIT instruction is executed Peripheral clock off	—	2.8	33	μA
			Off	32 kHz	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 VCA20 = 1 CM02 = 1 CM01 = 0	While a WAIT instruction is executed Peripheral clock off Timer RH operation in real-time clock mode LCD drive control circuit (4) When external division resistors are used	—	4.6	—	μA
			Off	32 kHz	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 VCA20 = 1 CM02 = 1 CM01 = 1	While a WAIT instruction is executed Peripheral clock off Timer RH operation in real-time clock mode	—	2.4	—	μA
		Stop mode	Off	Off	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 CM10 = 1	Topr = 25°C Peripheral clock off	—	0.5	2.2	μA
			Off	Off	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 CM10 = 1	Topr = 85°C Peripheral clock off	—	1.2	—	μA
		Power-off mode	Off	Off	Off	Off	—	—	Power-off 0 Topr = 25°C	—	0.01	0.1	μA
			Off	Off	Off	Off	—	—	Power-off 0 Topr = 85°C	—	0.03	—	μA
			Off	32 kHz	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 CM10 = 1	Power-off 2 Topr = 25°C	—	1.8	6.4	μA
			Off	32 kHz	Off	Off	—	VCA27 = 0 VCA26 = 0 VCA25 = 0 CM10 = 1	Power-off 2 Topr = 85°C	—	2.7	—	μA

Notes:

1. V_{CC} = 4.0 V to 5.5 V, single chip mode, output pins are open, and other pins are V_{SS}.
2. XIN is set to square wave input.
3. V_{CC} = 5.0 V
4. VLCD = V_{CC}, external division resistors are used for VL3 to VL1, 1/3 bias, 1/4 duty, f(FR) = 64 Hz, SEG0 to SEG39 are selected, and segment and common output pins are open. The standard value does not include the current that flows through external division resistors.

Table 5.49 DC Characteristics (3) [$2.7\text{ V} \leq V_{CC} < 4.0\text{ V}$]
($T_{opr} = -20\text{ to }85^{\circ}\text{C}$ (N version)/ $-40\text{ to }85^{\circ}\text{C}$ (D version), unless otherwise specified.)

Symbol	Parameter		Condition		Standard			Unit
					Min.	Typ.	Max.	
VOH	Output “H” voltage		Port P7_0, P7_1, P8 (1)	IOH = −5 mA	Vcc − 0.5	−	Vcc	V
			Other pins	IOH = −1 mA	Vcc − 0.5	−	Vcc	V
VOL	Output “L” voltage		Port P7_0, P7_1, P8 (1)	IOL = 5 mA	−	−	0.5	V
			Other pins	IOL = 1 mA	−	−	0.5	V
VT+-VT-	Hysteresis	<u>INT0</u> , <u>INT1</u> , <u>INT2</u> , <u>INT3</u> , <u>INT4</u> , <u>INT5</u> , <u>INT6</u> , <u>INT7</u> , <u>KI0</u> , <u>KI1</u> , <u>KI2</u> , <u>KI3</u> , <u>KI4</u> , <u>KI5</u> , <u>KI6</u> , <u>KI7</u> , TRCIOA, TRCIOB, TRCIOC, TRCIOD, TRJ0IO, TRJ1IO, TRJ2IO, TRCTRG, TRCCLK, ADTRG, RXD0, RXD2, CLK0, CLK2, SSI, SCL, SDA, SSO			0.05	0.4	−	V
		<u>RESET</u> , <u>WKUP0</u>						
IIH	Input “H” current		VI = 3 V, Vcc = 3 V		−	−	5.0	μA
IIL	Input “L” current		VI = 0 V, Vcc = 3 V		−	−	−5.0	μA
RPULLUP	Pull-up resistance		VI = 0 V, Vcc = 3 V		25	80	140	kΩ
RfXIN	Feedback resistance	XIN			−	2.0	−	MΩ
RfXCIN	Feedback resistance	XCIN			−	14	−	MΩ
VRAM	RAM hold voltage		During stop mode		1.8	−	−	V

Note:

1. This applies when the drive capacity of the output transistor is set to High by registers P7DPR and P8DPR. When the drive capacity is set to Low, the value of any other pin applies.

Table 5.51 DC Characteristics (5) [$1.8\text{ V} \leq V_{CC} < 2.7\text{ V}$]
($T_{opr} = -20\text{ to }85^{\circ}\text{C}$ (N version)/ $-40\text{ to }85^{\circ}\text{C}$ (D version), unless otherwise specified.)

Symbol	Parameter		Condition		Standard			Unit
					Min.	Typ.	Max.	
VoH	Output “H” voltage		Port P7_0, P7_1, P8 (1)	IoH = −2 mA	Vcc − 0.5	−	Vcc	V
			Other pins	IoH = −1 mA	Vcc − 0.5	−	Vcc	V
VoL	Output “L” voltage		Port P7_0, P7_1, P8 (1)	IoL = 2 mA	−	−	0.5	V
			Other pins	IoL = 1 mA	−	−	0.5	V
VT+-VT-	Hysteresis	INT0, INT1, INT2, INT3, INT4, INT5, INT6, INT7, KI0, KI1, KI2, KI3, KI4, KI5, KI6, KI7, TRCIOA, TRCIOB, TRCIOA, TRCIOB, TRCIOA, TRCIOB, TRJ0IO, TRJ1IO, TRJ2IO, TRCTRG, TRCCLK, ADTRG, RXD0, RXD2, CLK0, CLK2, SSI, SCL, SDA, SSO			0.05	0.4	−	V
		RESET, WKUP0			0.1	0.8	−	V
IiH	Input “H” current		Vi = 1.8 V, Vcc = 1.8 V		−	−	4.0	μA
IiL	Input “L” current		Vi = 0 V, Vcc = 1.8 V		−	−	−4.0	μA
RPULLUP	Pull-up resistance		Vi = 0 V, Vcc = 1.8 V		85	220	500	kΩ
RfXIN	Feedback resistance	XIN			−	2.0	−	MΩ
RfXCIN	Feedback resistance	XCIN			−	14	−	MΩ
VRAM	RAM hold voltage		During stop mode		1.8	−	−	V

Note:

1. This applies when the drive capacity of the output transistor is set to High by registers P7DPR and P8DPR. When the drive capacity is set to Low, the value of any other pin applies.